## Issue Classification | 10574920



Application/Control	No.

YUN QIAN

Examiner

Applicant(s)/Patent Under Reexamination MIYAZAWA ET AL.

Art Unit

1732

ORIGINAL								INTERNATIONAL CLASSIFICATION												
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Examiner Art Unit 1732	04/22/2011	Total Claims Allowed:			
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/Melvin C Mayes/ Supervisory Patent Examiner.Art Unit 1732	04/23/2011	O.G. Print Claim(s)	O.G. Print Figure		
(Primary Examiner)	(Date)	1	1		